

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 257517US2PCT		SERIAL NO. New U.S. PCT Application Based on PCT/JP02/05186	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Naohito TOMOE, et al.			
FILING DATE Herewith				GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	AA	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
/EBK/	AO	2002-024201	01/25/02	JP(with English abstract, & equivalent of US 2002-26553)		NO	
/EBK/	AP	9-064811	03/07/97	JP(with English abstract)		NO	
/EBK/	AQ	2001-154873	06/08/01	JP(with English abstract, & equivalent of US 6684348)		NO	
/EBK/	AR	7-260885	10/13/95	JP(with English abstract)		NO	
/EBK/	AS	6-214819	08/05/94	JP(with English abstract)		NO	
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Eric B. Kiss/		Date Considered 08/09/2007	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

FEB 01 2005

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
257517US2PCTSERIAL NO.
10/508,846

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Naohito TOMOE, et al.FILING DATE
September 23, 2004

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/EBK/	AO	08-265246	10/11/96	JP (with English abstract)		NO
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner /Eric B. Kiss/

Date Considered 08/09/2007

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Naohito TOMOE, et al.			
				FILING DATE September 23, 2004		GROUP 2192	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/EBK/	AA	2002/0026553 A1	02/28/2002	Toshitada SAITO (corr. to JP 2002-24201 previously filed on September 23, 2004)			
	AB						
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/EBK/	AO	9-64811	03/07/1997	JAPAN (submitting English translation only, reference previously filed on September 23, 2004)	X		
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner				/Eric B. Kiss/		Date Considered 08/09/2007	
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